Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,434	WESCHLER, RICHARD	
Examiner	Art Unit	
IOHN BAK	1616	

	SEARCHED					
Class	Subclass	Date	Examiner			
424	76.5,76.8 76.9,600 618,619 630,637 641,646	8/05				
	641,646 647,725 742,774		Como			
514	699		/ 10			
502	770 84,406 517	\downarrow				
		-				
		100000				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
WEST-PGPB,USPT, JPAB, Dupi See printant	7/05	M		
STN - HCaplus, WPIDS, CABA, BIOSIS Reg See printont	7/05	900		
WEST-PGPB, USPT, JPAB, DWPI See Printant	8/05	W.		
STN - Environment Cluster See Printant	8105	B		
Used STIC NPL Site \$ Used Scirus, Proquest, Adricola to search (Landfill and Fuller's earth)	8/05	SP		